## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10580352	TAKASHI ET AL.
Examiner	Art Unit
Stefan Kruer	3654

SEARCHED						
Class	Subclass	Date	Examiner			
187	351,356,367,378,379, 371, 372, 374	03/30/2008	SHK			
104	252, 257					

SEARCH NOTES				
Search Notes	Date	Examiner		
PLUS	03/30/2008	SHK		
248 + word				

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20080330